## Notice of References Cited Application/Control No. 10/808,818 Examiner Emmanuel S. Luk Applicant(s)/Patent Under Reexamination JEON ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	А	US-3,438,393	04-1969	GODLEY PHILIP	137/533.17
*	В	US-4,349,044	09-1982	Schirmer, Karl	137/512.3
*	С	US-4,850,851	07-1989	Dinerman, Alex	425/562
*	D	US-5,439,633	08-1995	Durina et al.	264/328.17
*	E	US-2004/0253335	12-2004	Anderson et al.	425/205
*	F	US-4,477,242	10-1984	Eichlseder et al.	425/207
*	G	US-4,472,058	09-1984	Pirro, Armand A.	366/78
	Н	US-			
	-	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	Р					
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	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	x	

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